





N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C		
60V	$6\Omega @ V_{GS} = 5V$	200mA		

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(ON)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Motor Control
- Power Management Functions

Features and Benefits

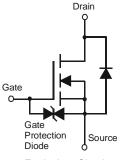
- N-Channel MOSFET
- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Small Surface Mount Package
- ESD Protected Gate, 1.2kV HBM
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

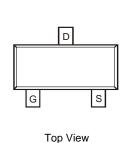
- Case: SOT23
- Case Material: Molded Plastic. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Alloy 42 leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Terminal Connections: See Diagram
- Weight: 0.008 grams (approximate)











Pin-Out

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Ordering Information (Note 4)

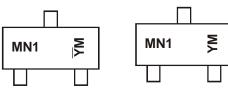
Part Number	Case	Packaging
2N7002A-7	SOT23	3,000/Tape & Reel
2N7002A-13	SOT23	10.000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.



Marking Information



Chengdu A/T Site Shanghai A/T Site

Date Code Key

Year	2008		2009	2010		2011	2012		2013	2014		2015
Code	V		W	X		Υ	Z		Α	В		С
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D

MN1 = Product Type Marking Code

Y or \overline{Y} = Year (ex: A = 2013) M = Month (ex: 9 = September)

YM = Date Code Marking for SAT (Shanghai Assembly/ Test site) YM = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Drain-Source Voltage		V_{DSS}	60	V
Gate-Source Voltage	_	V _{GSS}	±20	V
Continuous Drain Current (Note 5) $V_{GS} = 10V$ Steady State $ T_A = +25^{\circ}C $ $ T_A = +85^{\circ}C $ $ T_A = +100^{\circ}C $		Ι _D	180 130 115	mA
Continuous Drain Current (Note 6) $V_{GS} = 10V$ $Steady State$ $T_A = +25^{\circ}C$ $T_A = +85^{\circ}C$ $T_A = +100^{\circ}C$		Ι _D	220 160 140	mA
Maximum Continuous Body Diode Forward Current	(Note 6)	Is	0.5	Α
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	800	mA	

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Total Power Dissipation	(Note 5)	Ь	370	mW	
Total Fower Dissipation	(Note 6)	P_{D}	540		
Thermal Resistance, Junction to Ambient	(Note 5)	Б	348		
Thermal Resistance, Junction to Ambient	(Note 6)	$R_{ heta JA}$	241	°C/W	
Thermal Resistance, Junction to Case	(Note 6)	$R_{\theta JC}$	91		
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C	

Notes:

- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout
- 6. Device mounted on 1" x 1" FR-4 PCB with high coverage 2oz. Copper, single sided.

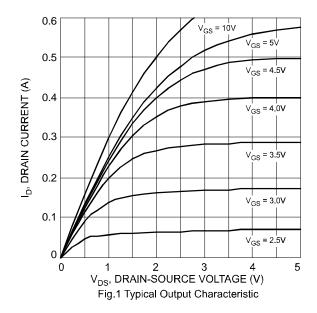


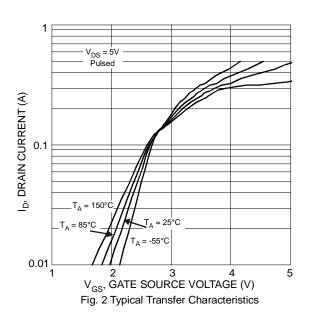
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						-	
Drain-Source Breakdown Voltage		BV _{DSS}	60	70		V	$V_{GS} = 0V, I_D = 10\mu A$
Zero Gate Voltage Drain Current	@ T _C = +25°C @ T _C = +125°C	I _{DSS}	_	_	1.0 500	μA	V _{DS} = 60V, V _{GS} = 0V
Gate-Body Leakage		I _{GSS}	_	_	±10	μA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						-	
Gate Threshold Voltage		V _{GS(th)}	1.2	_	2.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	@ T _J = +25°C	D		3.5	6	Ω	$V_{GS} = 5.0V, I_D = 0.115A$
	@ $T_J = +125$ °C	R _{DS(ON)}		3.0	5		V _{GS} = 10V, I _D = 0.115A
Forward Transconductance		g _{FS}	80	_	_	mS	V _{DS} = 10V, I _D = 0.115A
DYNAMIC CHARACTERISTICS (Note	8)						
Input Capacitance		C _{iss}	_	23		pF	
Output Capacitance		Coss	_	3.4	_	pF	$V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz$
Reverse Transfer Capacitance		C _{rss}	_	1.4	_	pF	
Gate Resistance		R _G	_	260	400	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
SWITCHING CHARACTERISTICS (No	te 8)					•	
Turn-On Delay Time		t _{D(ON)}		10	_	ns	$V_{DD} = 30V$, $I_D = 0.115A$, $R_L = 150\Omega$,
Turn-Off Delay Time		t _{D(OFF)}	_	33		ns	$V_{GEN} = 10V$, $R_{GEN} = 25\Omega$

Notes:

- 7. Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to product testing.







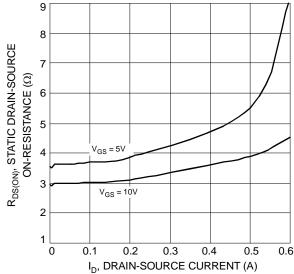


Fig. 3 On-Resistance vs. Drain Current & Gate Voltage

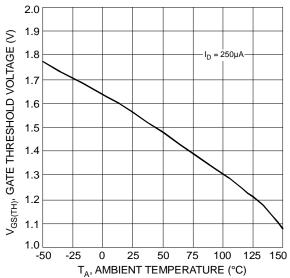


Fig. 5 Gate Threshold Variation vs. Ambient Temperature

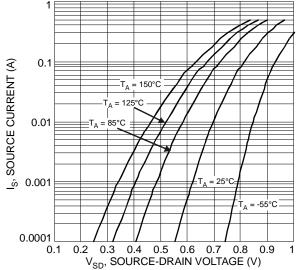


Fig. 7 Reverse Drain Current vs. Source-Drain Voltage

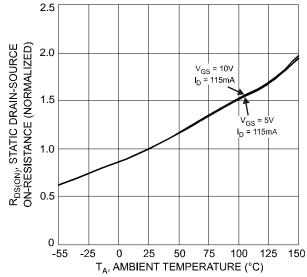
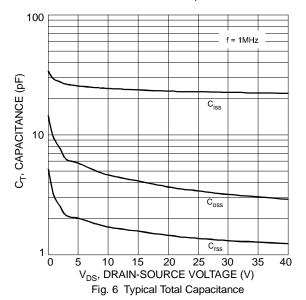


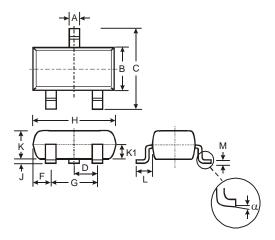
Fig. 4 Normalized Static Drain-Source On-Resistance vs. Ambient Temperature





Package Outline Dimensions

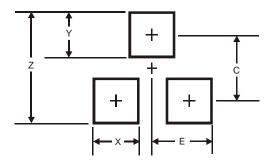
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SOT23						
Dim	Min	Max	Тур				
Α	0.37	0.51	0.40				
В	1.20	1.40	1.30				
С	2.30	2.50	2.40				
D	0.89	1.03	0.915				
F	0.45	0.60	0.535				
G	1.78	2.05	1.83				
Н	2.80	3.00	2.90				
7	0.013	0.10	0.05				
K	0.903	1.10	1.00				
K 1	-	-	0.400				
L	0.45	0.61	0.55				
М	0.085	0.18	0.11				
α	0°	8°	-				
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.9
Х	0.8
Υ	0.9
С	2.0
Е	1.35

July 2013



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